



INTERNATIONAL ATOMIC ENERGY AGENCY
UNITED NATIONS EDUCATIONAL, SCIENTIFIC AND CULTURAL ORGANIZATION
INTERNATIONAL CENTRE FOR THEORETICAL PHYSICS
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UNITED NATIONS INDUSTRIAL DEVELOPMENT ORGANIZATION



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**ICTP-INFN
SECOND COURSE ON BASIC VLSI DESIGN TECHNIQUES
18 February - 15 March 1991**

***Additional material to lectures
by***

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These are preliminary lecture notes, intended only for distribution to participants.

ADDITIONAL MATERIAL

TO LECTURES

IS MATHEMATICS S.A.B.

OP AMP DESIGN

References

1. P.R.Gray, R.G.Meyer, MOS Operational Amplifier Design: A tutorial Overview, IEEE JSSC, Dec. 1982, pp 969-982.
2. D.A.Hodges, P.R.Gray and R.W. Broderon "Potential of MOS Technologies for Analog Integrated Circuits", IEEE, JSSC, June 1978, pp 285-293.
3. R.K.Ahuja, "An improved frequency compensating technique for CMOS operational amplifiers," IEEE JSSC, Dec. 1983 pp 629-633.
4. D.B.Ribner, M.A. Copeland, "Design techniques for cascaded CMOS opamp with improved PSRR and Common-mode input range", IEEE JSSC, Dec. 84, pp 919-925.
5. K.E.Brehmer, J.B.Wieser, "Large swing CMOS Power amplifier", IEEE JSSC, Dec. '83, pp 624-628.
6. "Design Note of a CMOS Push Pull Power amplifier", LSI Design Department.
7. Abe et al, "A single chip CMOS A/D and D/A converter for PCM audio use", IEEE Trans. on Consumer Electronics, Nov. 1984, pp 323-325.

OTA DESIGN

REFERENCES

1. "Active filter design using OTA: A Tutorial" by Donald L. Geiger and Edger S.S. IEEE circuits devices magazine March. 1985.
2. The design of high performance Analog circuits digital CMOS chips. Ems A. Vittoz, J.S.S.C. June 1985.
3. Technological design considerations for monolithic MOS SC filtering systems. David I. Austor, William C. Blade is IEEE proceedings August 1983. pp 977.
4. F. Krummeracher "High voltage Gain CMOS OTA for micro power SC filters." Electron Lett. Vol. 17, pp 160-162, Feb. 1981.
5. M.R. Degrauwe, F. Willy, M. Sansen. "The current efficiency of MOS transconductance amplifiers." J.S.S.C., June 1984. (Simulations could not be reported)
6. T.C. Choi, R.T. Kawashro et al "High frequency SC filters for communication application." J.S.S.C. Dec. 1983 ref to pp 659-661.
7. M. Degrauwe, E. Vittoz, I. Verbauwhe. "A micropower CMOS instrumentation amplifier." J.S.S.C. June 1985.
8. Peter M. Vanipetegh, I. Verbauwhe, A.W.M.C. Sansen. "Micropower high performance SC building block for integrated low level signal processing." J.S.S.C. August 1985.
9. Ignatius SAB. "OTA for special comparator instrumentation". DVM. April 1984 ibid 1985.
10. Current mirror documentation ibid 1984.
11. Miran Milkovic "Current Gain high frequency CMOS operational amplifiers" J.S.S.C. August 1985.
12. Eric A. Vittoz. "MOS transistors operated in bipolar mode and their appl. for CMOS technology J.S.S.C. June 1983.
13. B.J. Mosticka, Dynamic CMOS amplifiers J.S.S.C. vol. SC-15 pp 887-894 Oct. 1980.
14. M.C. Degrauwe et al. "Adaptive Biasing of CMOS amplifiers" J.S.S.C. Vol. 17. pp 572-578, June 1982.

VOLTAGE REFERENCES

(3) If desired, for achieving higher accuracy modelling of breakdown behaviour, more accurate zener models (g) may be implemented on the circuit simulator.

REFERENCES

1. S.M.Sze. "Physics of Semiconductor Devices", Wiley Eastern Ltd. p.133.
2. P.Gray, and R.G.Meyer, "Analysis and Design of Analog Integrated Circuits" John Wiley and Sons, pp.248-261.
3. R.J.Widlar, "New Developments in IC Voltage regulators", IEEE Journal of Solid State Circuits, Vol.SC-6, No. 1. February 1971 pp.2-7.
4. K.E.Kuijtk, "A precision reference voltage source", IEEE Journal of Solid State Circuits, vol SC-8, No.3 June 1973, pp. 222-226.
5. R.Ye and Y.Tsividis, "Band gap voltage reference source in CMOS Technology", "Electronics Letters, vol. 18, No.1 7th Jan. 1982, pp. 24-25.
6. R.A. Blauschild, P.A.Tucci, R.S.Muller and R.G.Meyer, "A new NMOS Temperature Stable voltage Reference", "IEEE Journal of Solid State Circuits, vol. SC-13, No.6, Dec.1978 pp.767.774.
7. S.A.B. Ignatius, "Specifications for zener reference".
8. S.Lui. R.G.Meyer and Norman Kwan, "An ion-implanted Subsurface monolithic zener diode". IEEE Journal of Solid State Circuits, vol. SC-14, No.4, Aug. 1979 pp.782-784.
9. A.K.Laha and D.W. Smart, "A zener diode model with application to SPICE-2", IEEE Journal of Solid State Circuits, Vol. SC-16, No.1, Feb. 1981, pp. 21-22.

the gap (etching width) between adjacent capacitor plates is more than 6 μm , ($A = 12\mu\text{m}$).

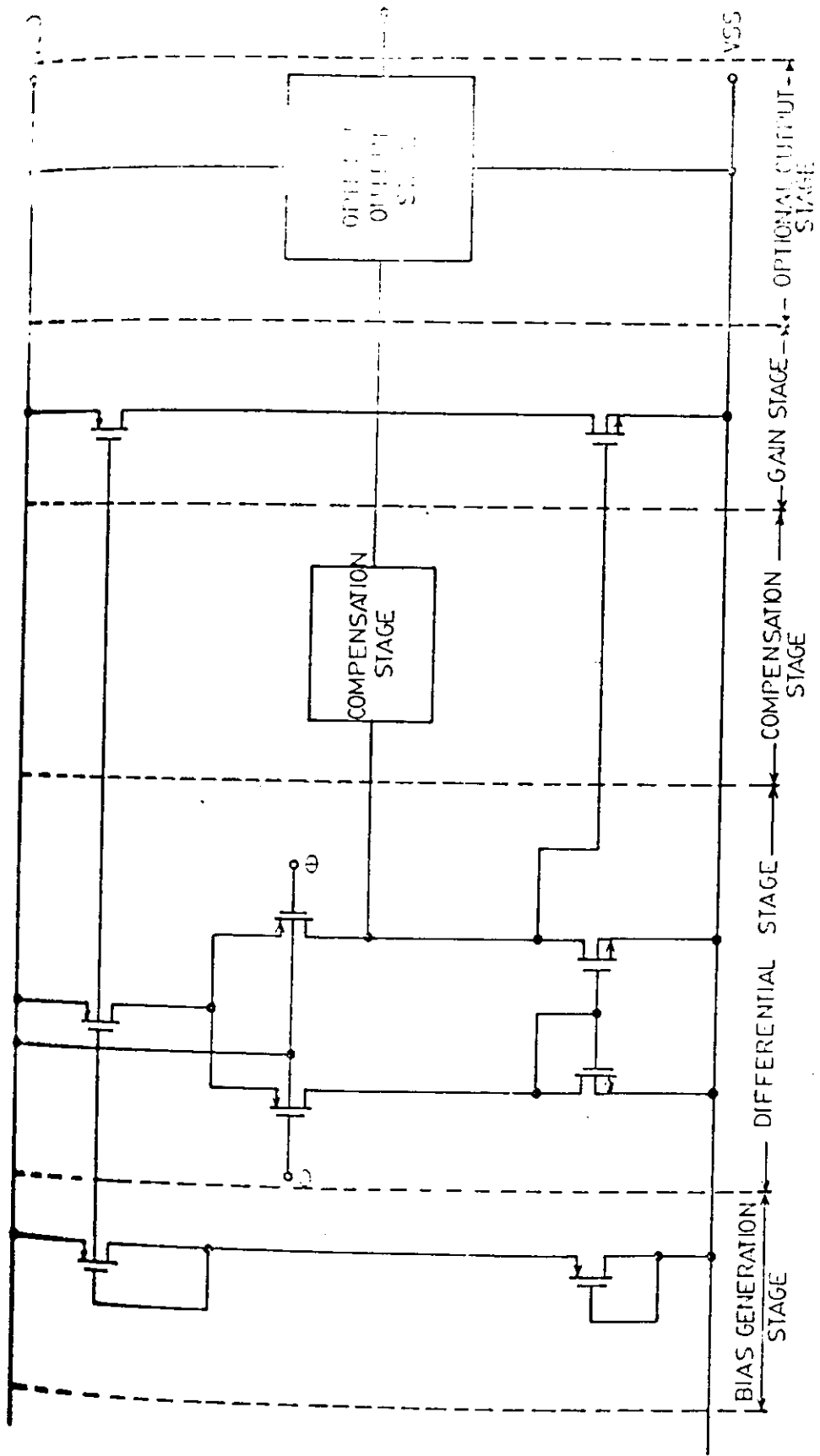
Measurements

It is intended that Measurements will be done by HP 4275A LCR meter. The most attractive feature of the instrument, which makes it suitable for low-capacitance measurements is that it can store a reference value (e.g. of a parasitic capacitance) & can later, subtract this value from the value being measured for the actual intended capacitance. Its like the zero setting of a conventional multimeter. Further it can measure the required minimum values of capacitances to an accuracy which is better than 8-bit, which is our requirement.

REFERENCES

1. Mc Creary, J.L. and P.R. Gray, "All-MOS charge Redistribution Analog-to-Digital conversion Techniques-Part I, "IEEE J.SSC. Dec. 75.
2. Suarez, P.E., P.R. Gray and D.A.Hodges, "All-MOS Charge Redistribution Analog-to-Digital Conversion Techniques" Part II", IEEE J.SSC. Dec. 1975.
3. Albarran, J.F. and D.A. Hodges, "A Charge-Transfer Multiplying Digital-to-Analog Converter", IEEE J.SSC, Dec. 1976.
4. New Comb, R, "Considerations in MOS Ratioed capacitor Layout". VLSI Design, Third Quarter 1981.
5. Smarandou, G, Hodges, Gray & Landsburg, "CMOS Pulse-Code-Modulation Voice Codec, "IEEE J.SSC, pp. 504-510, Aug. 1978.
6. J.L. Mc Creary, "Matching Properties, and Voltage and Temperature Dependence of MOS capacitors", IEEE J.SSC, Vol. SC-16, No.6, pp. 608-616.
7. Shyu, J.B., G.G. Temes & K. Yao "Random Errors in MOS Capacitors, "IEEE, J.SSC, Vol. SC-17, No.6, pp 1070-1076 Dec. 82.
8. Shyu, J.B., G.C. Temes and Francois Kruppenacher & "Random Error Effects in Matched MOS capacitors and current Sources", IEEE, J.SSC, Vol. SC-19. No. 6, pp. 948-955.
9. Shyu, J.B., "The obtainable Accuracy of analog MOS Integrated circuit elements, "Ph.D. Dissertation, Univ. California, Los Angeles, 1984.
10. Yee., Y.S.L.M. Terman & L.G. Heller, "A Two-Stage Weighted Capacitor Network for D/A-A/D conversion", IEEE J.SSC, vol. SC-14, No.4, pp. 778-781, Aug. 79.

11. Mc Creary, J.L. & D.A. Sealer, "Precision Capacitor Ratio Measurement Technique for Integrated circuit capacitor Arrays," IEEE, Trans. on Instrumentation and Measurement, vol. IM-28, No.1, March 1979.
12. Maddox.
13. Stone, D.C., J.E. Schoeder, R.H. Kaplan and A.R. Smith, "Analog CMOS Building Blocks for custom and Semi-custom Applications", IEEE, J.SSC, Vol. SC-19, No.1, February, 1984.
14. W.J. Helmes, "Fabrication of NMOS capacitors with a Low-Voltage Coefficient at a Silicon Foundry" IEEE, Electron Device letters, Vol. EDL-6, No.1, Jan. 1985.
15. Singh, S.P., A. Prabhakar, A.B. Bhattacharyya, "Modified C-2C Ladder Voltage Divider for Application in PCM A/D Convertors", Electronics Letters, 15t September, 1983, Vol. 19, No.19, pp. 788-789.
16. Singh, S.P., A. Prabhakar, A.B. Bhattacharyya, "C-2C Ladder voltage dividers for application in all MOS A/D convertors, "Electron. Lett., 1982, 18, pp. 537-538.
17. Allstot D.J. & W.C. Block Jr., "Technological Design Considerations for Monolithic MOS Switched-capacitor Filtering Systems, "Proc. of the IEEF, Vol. 71, No.8 Aug. 83.



BASIC OPAMP CONFIGURATION (P-TYPE)

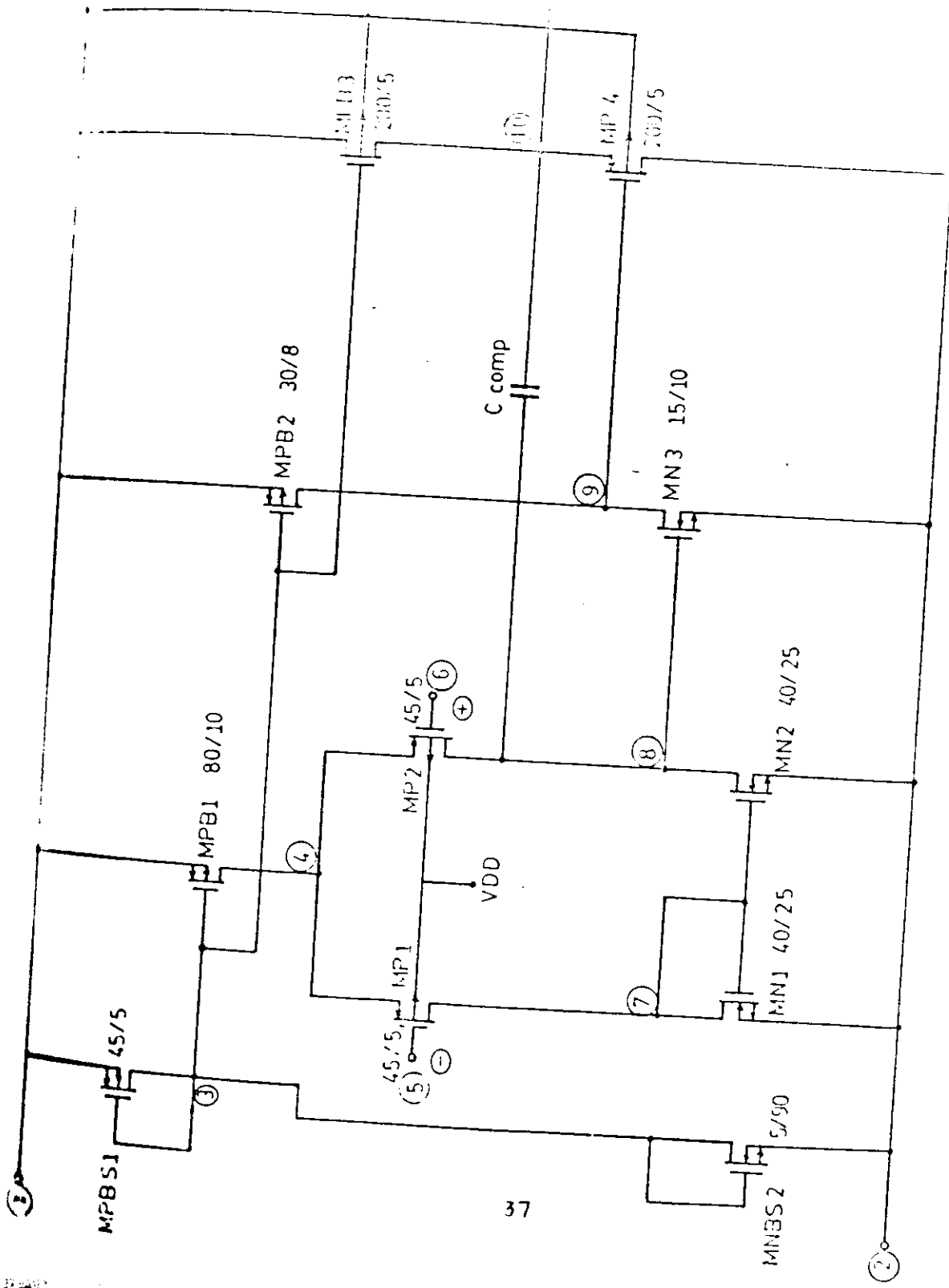
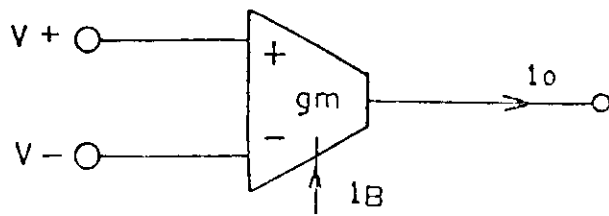
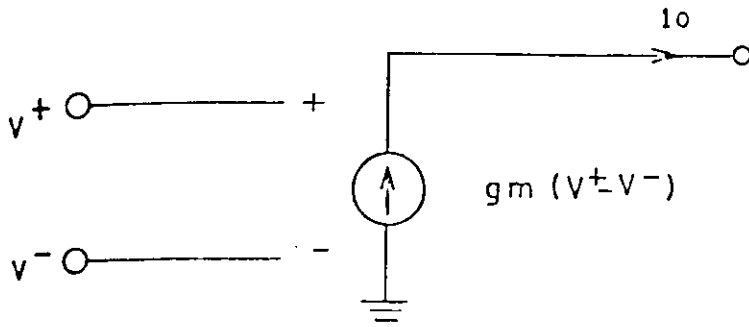


FIG. (d) COMPLETE OP AMP SCHEMATIC



FIG(1)a : OTA SUMBOL



FIG(1)b: EQUIVALENT CIRCUIT OF IDEAL OTA

FIG.(1): OTA SYMBOL AND MODEL

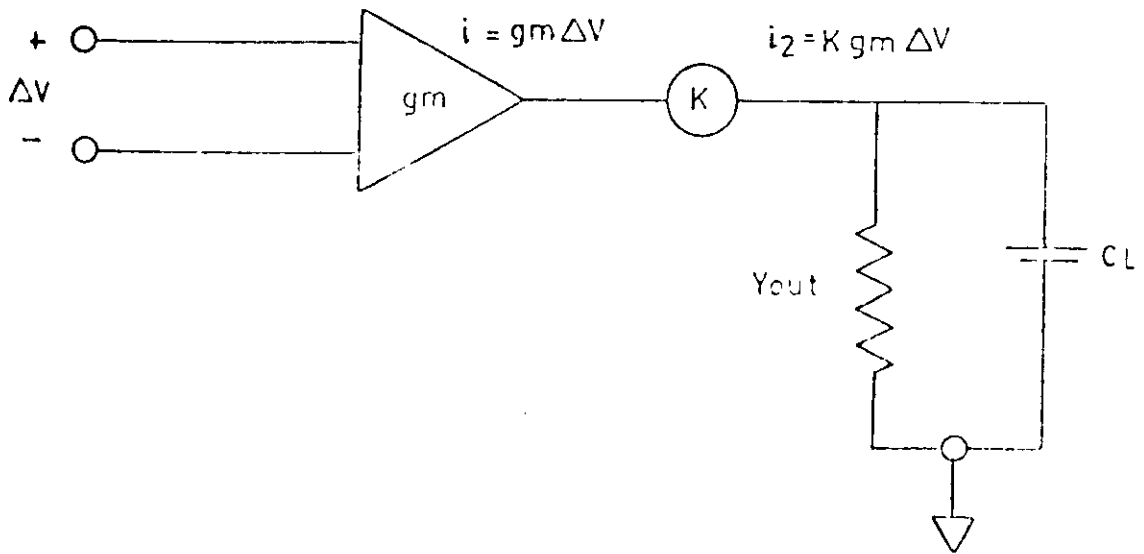


FIG.(2) a : OTA EQUIVALENT CIRCUIT

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AMPLIFIER

(1) VDD

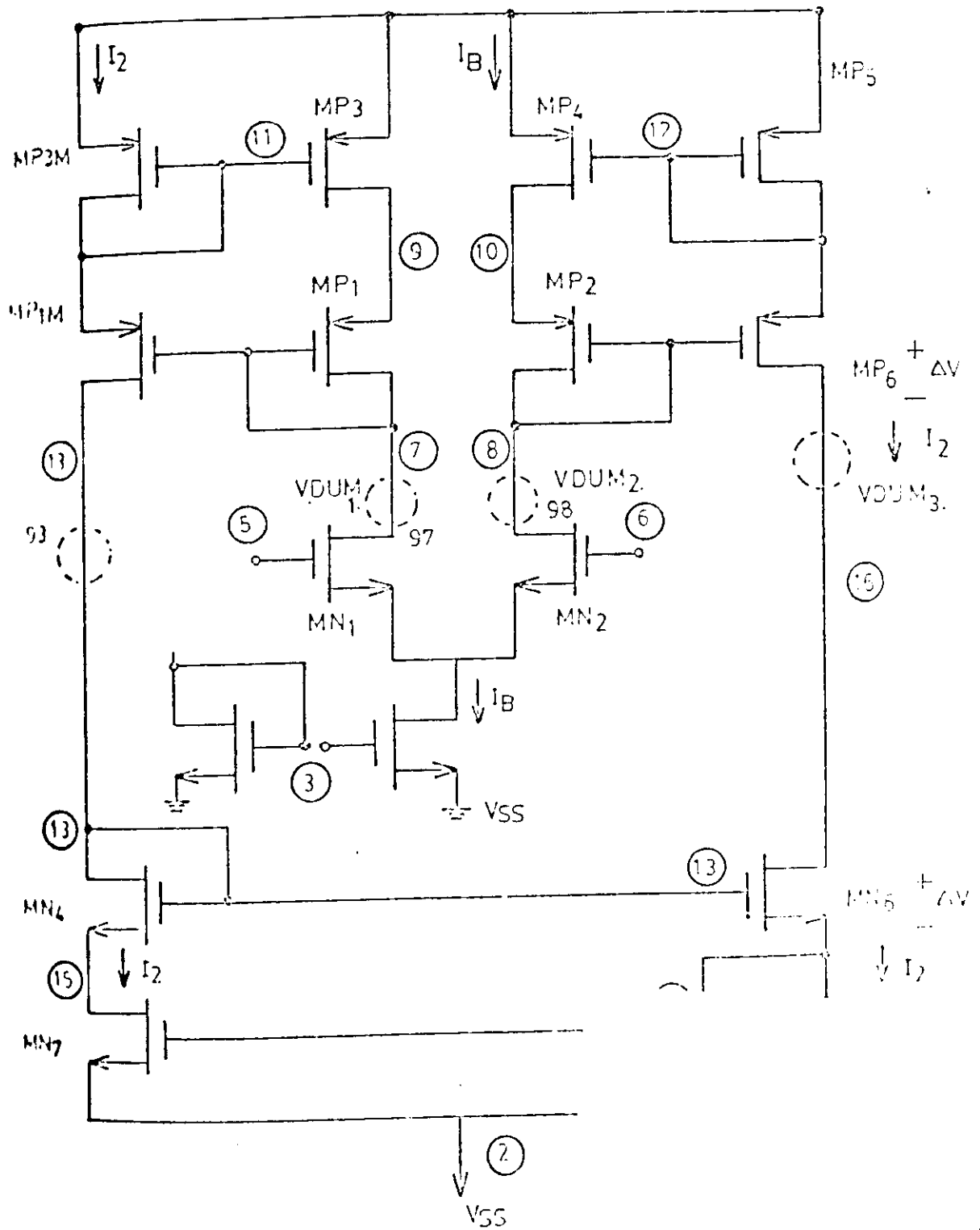


FIG.2(b) : COMPARATOR CIRCUIT

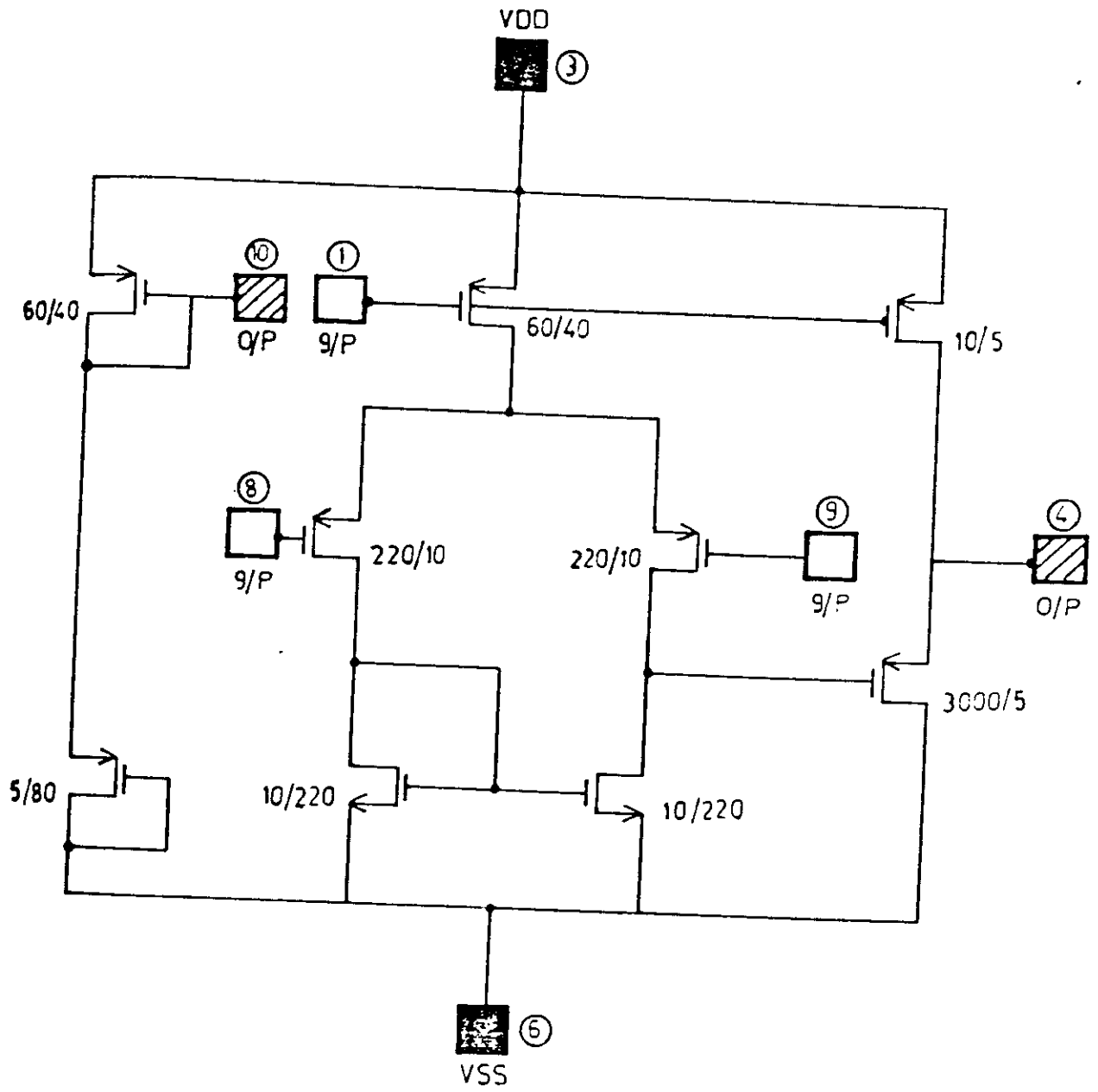


FIG. 2.- UNITY GAIN BUFFER WITH DEVICE SIZES

